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Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/082,450	ZHU ET AL.	
Examiner	Art Unit	
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	SEARCHED			
Class	Subclass	Date	Examiner	
370	386-388 text search updated	1/19/2009	НМ	
370	392	1/19/2009	НМ	
370	299	1/19/2009	НМ	
370	422	1/19/2009	НМ	

Subclass	Date	Examiner
	Subclass	Subclass Date

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Searched EAST DB:USPG-PUB, USPAT, JPO and EPO	1/19/2009	НМ	
Searched IEEE	1/19/2009	НМ	
Searched Palm Inventors DB	1/19/2009	НМ	